

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/758,905	LAO ET AL.	
Examiner		Art Unit		Page 1 of 1
Bernard Krasnic		2624		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0046311 A1	11-2001	Okano et al.	382/115
*	B	US-2002/0015514 A1	02-2002	Kinjo, Naoto	382/118
*	C	US-6,806,898 B1	10-2004	Toyama et al.	348/14.16
*	D	US-2004/0228505 A1	11-2004	Sugimoto, Masahiko	382/118
*	E	US-2005/0008246 A1	01-2005	Kinjo, Naoto	382/254
*	F	US-2005/0063566 A1	03-2005	Beek et al.	382/115
*	G	US-7,057,636 B1	06-2006	Cohen-Solal et al.	348/14.08
*	H	US-2006/0177110 A1	08-2006	Imagawa et al.	382/118
*	I	US-2006/0204055 A1	09-2006	Steinberg et al.	382/118
*	J	US-2006/0251299 A1	11-2006	Kinjo, Naoto	382/118
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001215403 A	08-2001	Japan	OWADA, MITSURU	G02B 07/28
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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